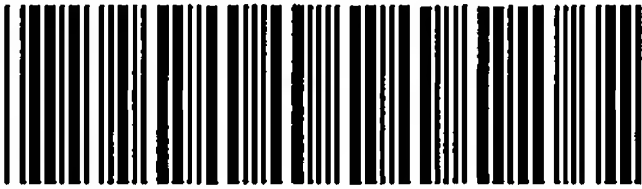


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/660,603	KANEKO ET AL.	
	Examiner	Art Unit	
	Lincoln Donovan	2832	

SEARCHED			
Class	Subclass	Date	Examiner
336	83, 90-98 192 198	12/4/2004	LD

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Tuyen Nguyen	12/4/2004	LD